Docket No.: 67161-067 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Kiyoshi MAESHIMA

:

Serial No.: : Group Art Unit:

Filed: July 17, 2003 : Examiner:

For: PHOTO MASK, METHOD OF MANUFACTURING ELECTRONIC DEVICE, AND

METHOD OF MANUFACTURING PHOTO MASK

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of three references listed on attached Form 1449 is discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Stephen A. Becker Registration No. 26,527

600 13th Street, N.W. Washington, DC 20005-3096 (202) 756-8000 SAB:mcw Facsimile: (202) 756-8087

Date: July 17, 2003

							SHEET TO	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION				ATTY. DOCKET NO. 67161-067	SERIAL NO.			
				APPLICANT Kiyoshi MAESHIMA				
(PTO-1449)				FILING DATE July 17, 2003				
			U.S. PATE	NT DOCUMENTS		2,014.00; 3.111		
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (# known)	Publication Da MM-DD-YYYY				es, Columns, Lines, Where evant Passages or Relevant Figures Appear	
		US						
		US						
	<u> </u>	US						
-	<u> </u>	US						
	<u> </u>	US						
	 	US	-					
	 	US						
	1	US						
	İ	US						
		US						
		US						
574141500	т	T		ATENT DOCUMENTS				
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY		Pages, Columns, Lines Where Relevant Figures Appear		Translation	
	ļ	ID 00 200225	40/40/4000	OUADD CODD			Yes	No
	ļ	JP 08-328235	12/13/1996	SHARP CORP			Japan (w/English Abstract)	
		JP 08-297357	11/12/1996	TOPPAN PRINTING CO LTD			Japan (w/English Abstract)	
		JP P2001-356467A	12/26/2001	TOPPAN PRINTING CO LTD			Japan (w/English Abstract)	
		JP 09-127677	05/16/1997	NEC CORP			Japan (w/English Abstract)	
		JP 08-292550	11/05/1996	TOPPAN PRINTING CO LTD			Japan (w/English Abstract)	
		JP 10-326009	12/08/1998	HITACHI LTD			Japan (w/English Abstract)	
				nor, Title, Date, Pertinent Pages, E				
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in journal, serial, symposium, cat published.	CAPITAL LETTER alog, etc.), date, p	RS), title of the article (when appro age(s), volume-issue number(s), p	priate), title of the publisher, city and/	item (bod or countr	ok, magazine, y where	
		"High transmission attenuated PSM - Benefits and Limitations through a validation study of 33%, 20%, and 6% transmission masks", N. Kachwala et al., Proceedings of SPIE Vol. 4000 (2000), pp. 1163-1174						
	1							
l	L							
EXAMINER					DATE CONSIDE	RED		
		0.00						

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.